Search Notes			

Application/Control No.	Applicant(s)/Patent und Reexamination	er
09/728,056	ARNAUD, PASCAL	
Examiner	Art Unit	
Shengjun Wang	1617	

SEARCHED				
Class	Subclass	Date	Examiner	
424	63,64 401	1/18/2008	SW	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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